











CSD17556Q5B

SLPS392D - MARCH 2013-REVISED NOVEMBER 2017

CSD17556Q5B 30-V N-Channel NexFET™ Power MOSFET

Features

- Extremely Low Resistance
- Ultra-Low Q_q and Q_{qd}
- Low-Thermal Resistance
- Avalanche Rated
- Lead-Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5-mm × 6-mm Plastic Package

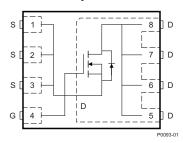
Applications

- Point of Load Synchronous Buck in Networking, Telecom, and Computing Systems
- Synchronous Rectification
- Active ORing and Hotswap Applications

3 Description

This 30-V, 1.2-m Ω , 5-mm × 6-mm NexFETTM power MOSFET is designed to minimize losses in synchronous rectification and other power conversion applications.





R_{DS(on)} vs V_{GS} 6 T_C = 25°C Id = 30A $R_{DS(on)}$ - On-State Resistance $(m\Omega)$ $T_C = 125^{\circ}C \text{ Id} = 30A$ 5 4 3 2 1 0 6 8 0 2 10 12 V_{GS} - Gate-to- Source Voltage (V) G001

Product Summary

$T_A = 25^\circ$	С	TYPICAL V	UNIT	
V_{DS}	Drain-to-Source Voltage	30	V	
Q_g	Gate Charge Total (4.5 V)	30	nC	
Q_{gd}	Gate Charge Gate-to-Drain	7.5	nC	
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 4.5 V 1.5		mΩ
	Drain-to-Source On-Resistance	V _{GS} = 10 V 1.2		
$V_{GS(th)}$	Threshold Voltage	1.4	V	

Device Information⁽¹⁾

DEVICE	QTY	MEDIA	PACKAGE	SHIP
CSD17556Q5B	2500		SON	Tape
CSD17556Q5BT	250	13-Inch Reel	5.00-mm × 6.00-mm Plastic Package	and Reel

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

Absolute Maximum Rutings									
$T_A = 2$	25°C	VALUE	UNIT						
V_{DS}	Drain-to-Source Voltage	30	V						
V_{GS}	Gate-to-Source Voltage	±20	V						
I _D	Continuous Drain Current (Package Limited)	100							
	Continuous Drain Current (Silicon Limited), $T_C = 25$ °C	215	Α						
	Continuous Drain Current ⁽¹⁾	34							
I _{DM}	Pulsed Drain Current, T _A = 25°C ⁽¹⁾⁽²⁾	400	Α						
-	Power Dissipation ⁽¹⁾	3.1	10/						
P_D	Power Dissipation, T _C = 25°C	191	W						
T _J , T _{stg}	Operating Junction, Storage Temperature	-55 to 150	့						
E _{AS}	Avalanche Energy, Single Pulse $I_D = 100 \text{ A}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	500	mJ						

- (1) Typical $R_{\theta JA} = 40^{\circ}C/W$ on $1-in^2$ (6.45-cm²), (0.071-mm) thick Cu pad on a 0.06-inch (1.52-mm) thick FR4
- (2) Max $R_{\theta JC}$ = 1.3°C/W, pulse duration ≤ 100 μs , duty cycle ≤ 1%.

Gate Charge

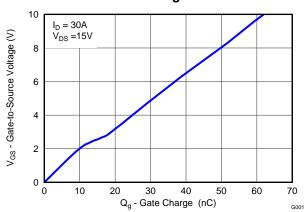




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4	Revision History	
Ch	nanges from Revision C (January 2017) to Revision D	Page
•	Corrected front page formatting error	1
Ch	nanges from Revision B (August 2014) to Revision C	Page
•	Changed part numbers in the Device Information table	1
•	Added Receiving Notification of Documentation Updates section and Community Resources section to the Device and Documentation Support section	
Ch	nanges from Revision A (October 2013) to Revision B	Page
•	Increased max pulsed drain current to 400 A.	1
•	Updated pulsed drain current conditions	1
•	Updated Figure 1 to a normalized R _{eJC} curve	4
•	Updated the SOA in Figure 10	6
•	Updated the mechanical drawing and dimensions table to show previously unknown dimensions	8
Ch	nanges from Original (March 2013) to Revision A	Page
•	Updated the dimensions table in the Mechanical Data Section to include DIM "H" values	8

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5 Specifications

5.1 Electrical Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _{DS} = 250 μA	30			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0 V, V _{DS} = 24 V			1	μА
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	1.15	1.4	1.65	V
	David to a second of the secon	V _{GS} = 4.5 V, I _{DS} = 40 A		1.5	1.8	0
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 10 V, I _{DS} = 40 A		1.2	1.4	mΩ
9 _{fs}	Transconductance	V _{DS} = 15 V, I _{DS} = 40 A		197		S
DYNAMI	IC CHARACTERISTICS	<u>, </u>			1	
C _{iss}	Input capacitance			5400	7020	рF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 15 \text{ V},$ f = 1 MHz		1770	2310	рF
C _{rss}	Reverse transfer capacitance	J = 1 181112		68	88	pF
R _G	Series gate resistance			0.7	1.4	Ω
Qg	Gate charge total (4.5 V)			30	39	nC
Q_{gd}	Gate charge gate-to-drain	V 45 V 1 40 A		7.5		nC
Q_{gs}	Gate charge gate-to-source	V _{DS} = 15 V, I _{DS} = 40 A		11		nC
Q _{g(th)}	Gate charge at V _{th}			6.1		nC
Q _{oss}	Output charge	V _{DS} = 15 V, V _{GS} = 0 V		48		nC
t _{d(on)}	Turnon delay time			14		ns
t _r	Rise time	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V},$		26		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 40 \text{ A}, R_G = 2 \Omega$		27		ns
t _f	Fall time			12		ns
DIODE C	CHARACTERISTICS				<u>"</u>	
V _{SD}	Diode forward voltage	I _{SD} = 40 A, V _{GS} = 0 V		0.8	1	V
Q _{rr}	Reverse recovery charge	V 45.V L 40.A 45/44 202.A / -		68		nC
t _{rr}	Reverse recovery time	V_{DD} = 15 V, I_F = 40 A, di/dt = 300 A/ μ s		36		ns

5.2 Thermal Information

 $T_A = 25$ °C (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance ⁽¹⁾			1.3	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾⁽²⁾			50	C/VV

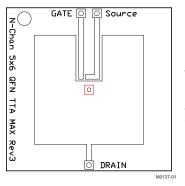
⁽¹⁾ R_{θJC} is determined with the device mounted on a 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu pad on a 1.5-in x 1.5-in (3.81-cm x 3.81-cm), 0.06-in (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.

(2) Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.

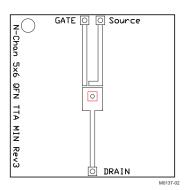
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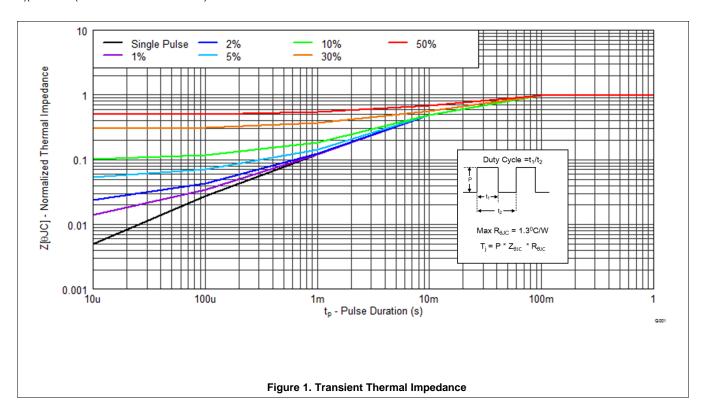
Max $R_{\theta JA} = 50^{\circ} C/W$ when mounted on 1-in² (6.45-cm²) of 2-oz (0.071-mm) thick Cu.



Max $R_{\theta JA} = 125^{\circ}\text{C/W}$ when mounted on a minimum pad area of 2-oz (0.071-mm) thick Cu.

5.3 Typical MOSFET Characteristics

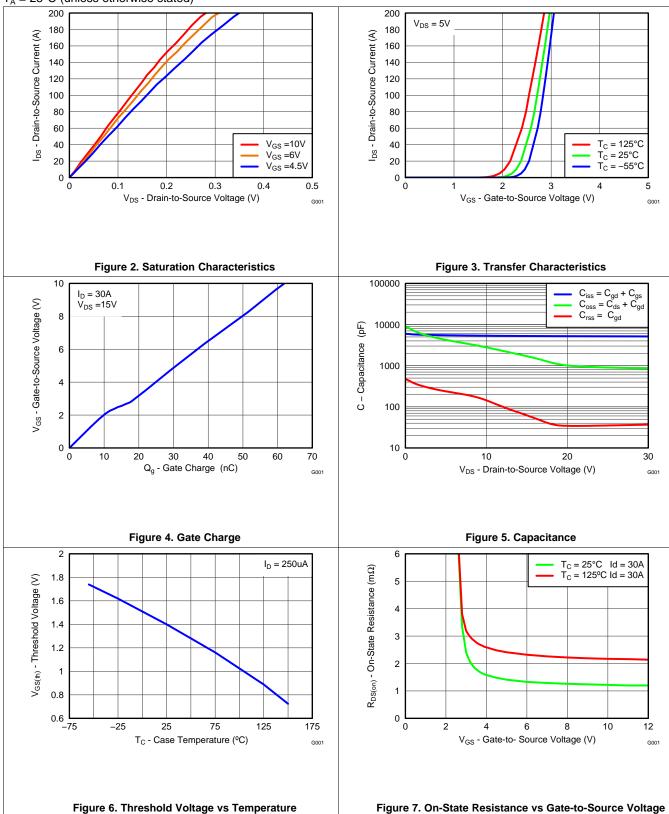
 $T_A = 25$ °C (unless otherwise stated)





Typical MOSFET Characteristics (continued)

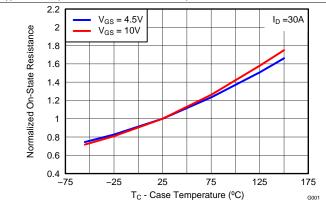
 $T_A = 25$ °C (unless otherwise stated)





Typical MOSFET Characteristics (continued)

 $T_A = 25$ °C (unless otherwise stated)



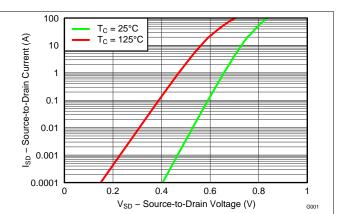


Figure 8. Normalized On-State Resistance vs Temperature

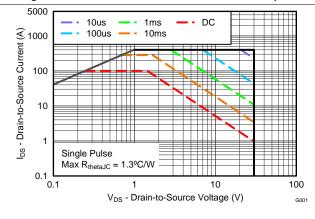


Figure 9. Typical Diode Forward Voltage

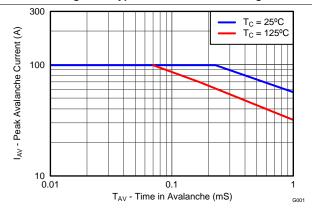


Figure 10. Maximum Safe Operating Area (SOA)



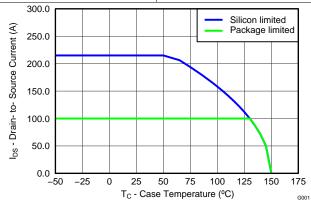


Figure 12. Maximum Drain Current vs Temperature

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6 Device and Documentation Support

6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.

All other trademarks are the property of their respective owners.

6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

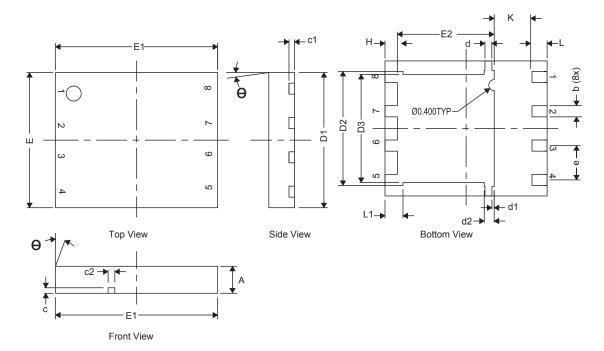
Product Folder Links: CSD17556Q5B



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Q5B Package Dimensions

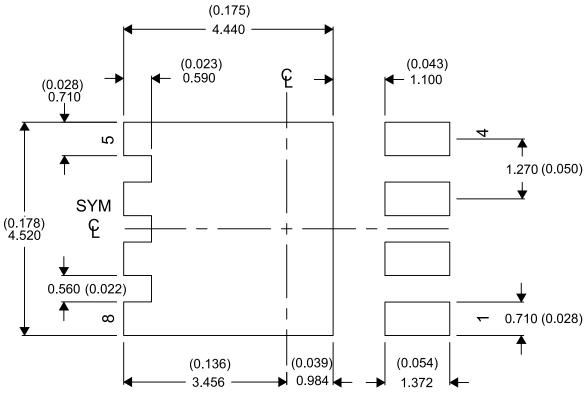


DIM		MILLIMETERS				
DIIVI	MIN	NOM	MAX			
Α	0.80	1.00	1.05			
b	0.36	0.41	0.46			
С	0.15	0.20	0.25			
c1	0.15	0.20	0.25			
c2	0.20	0.25	0.30			
D1	4.90	5.00	5.10			
D2	4.12	4.22	4.32			
D3	3.90	4.00	4.10			
d	0.20	0.25	0.30			
d1		0.085 TYP				
d2	0.319	0.369	0.419			
E	4.90	5.00	5.10			
E1	5.90	6.00	6.10			
E2	3.48	3.58	3.68			
е		1.27 TYP				
Н	0.36	0.46	0.56			
L	0.46	0.56	0.66			
L1	0.57	0.67	0.77			
θ	0°	_	_			
K		1.40 TYP				

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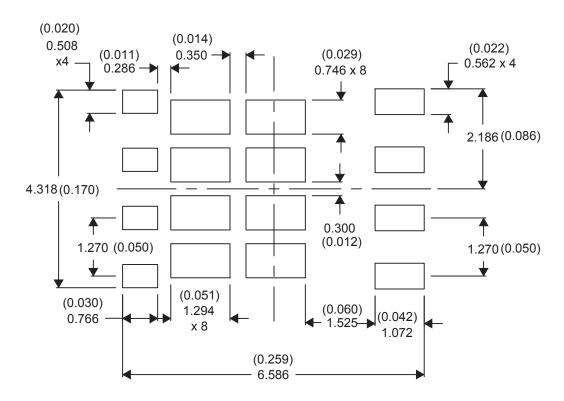


7.2 Recommended PCB Pattern



For recommended circuit layout for PCB designs, see *Reducing Ringing Through PCB Layout Techniques* (SLPA005).

7.3 Recommended Stencil Pattern

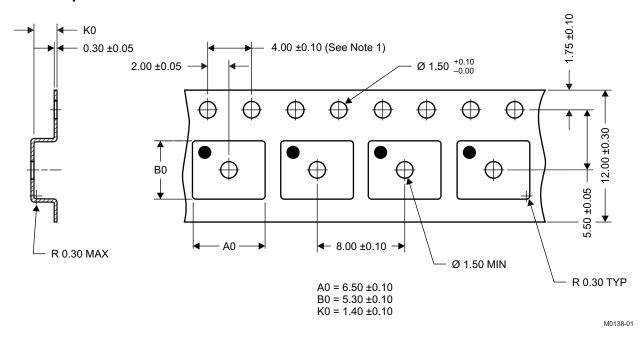


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7.4 Q5B Tape and Reel Information



Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2.
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm.
- 3. Material: black static-dissipative polystyrene.
- 4. All dimensions are in mm (unless otherwise specified).
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD17556Q5B	ACTIVE	VSON-CLIP	DNK	8	2500	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD17556	Samples
CSD17556Q5BT	ACTIVE	VSON-CLIP	DNK	8	250	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD17556	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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